

SANYO Semiconductors DATA SHEET

P-Channel Silicon MOSFET

MCH3315 — General-Purpose Switching Device **Applications**

Features

- · Low ON-resistance.
- · Ultrahigh-speed switching.
- 4V drive.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	VDSS		-60	V
Gate-to-Source Voltage	VGSS		±20	V
Drain Current (DC)	ID		-1	Α
Drain Current (Pulse)	IDP	PW≤10μs, duty cycle≤1%	-4	Α
Allowable Power Dissipation	PD	Mounted on a ceramic board (900mm ² X0.8mm)	0.9	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C

Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Linit
			min	typ	max	Unit
Drain-to-Source Breakdown Voltage	V(BR)DSS	ID=-1mA, VGS=0	-60			V
Zero-Gate Voltage Drain Current	IDSS	V _{DS} =-60V, V _{GS} =0			-1	μΑ
Gate-to-Source Leakage Current	IGSS	V _{GS} =±16V, V _{DS} =0			±10	μΑ
Cutoff Voltage	VGS(off)	VDS=-10V, ID=-1mA	-1.2		-2.6	V
Forward Transfer Admittance	yfs	V _{DS} =-10V, I _D =-0.5A	0.6	1.2		S
Static Drain-to-Source On-State Resistance	RDS(on)1	I _D =-0.5A, V _G S=-10V		580	760	mΩ
	RDS(on)2	ID=-0.3A, VGS=-4V		780	1100	mΩ
Input Capacitance	Ciss	V _{DS} =-20V, f=1MHz		180		pF
Output Capacitance	Coss	V _{DS} =-20V, f=1MHz		15		pF
Reverse Transfer Capacitance	Crss	VDS=-20V, f=1MHz		11		pF
Turn-ON Delay Time	t _d (on)	See specified Test Circuit.		8		ns
Rise Time	t _r	See specified Test Circuit.		3		ns
Turn-OFF Delay Time	t _d (off)	See specified Test Circuit.		30		ns
Fall Time	tf	See specified Test Circuit.		25		ns

Marking: JQ Continued on next page.

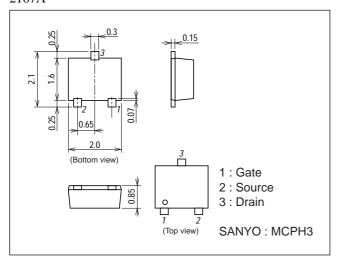
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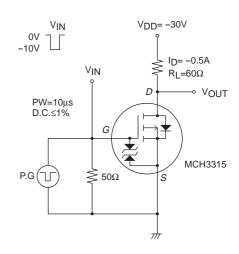
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	O III
Total Gate Charge	Qg	V _{DS} =-30V, V _{GS} =-10V, I _D =-1A		5		nC
Gate-to-Source Charge	Qgs	V _{DS} =-30V, V _{GS} =-10V, I _D =-1A		0.8		nC
Gate-to-Drain "Miller" Charge	Qgd	V _{DS} =-30V, V _{GS} =-10V, I _D =-1A		0.8		nC
Diode Forward Voltage	VSD	IS=-1A, VGS=0		-0.89	-1.2	V

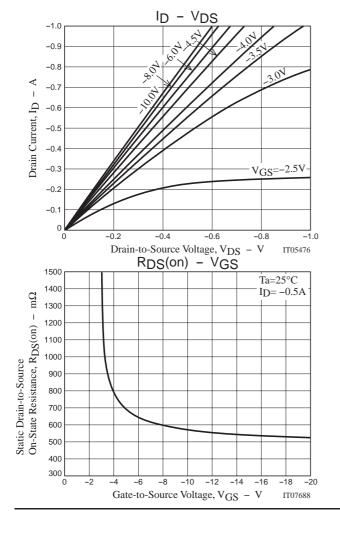
Package Dimensions

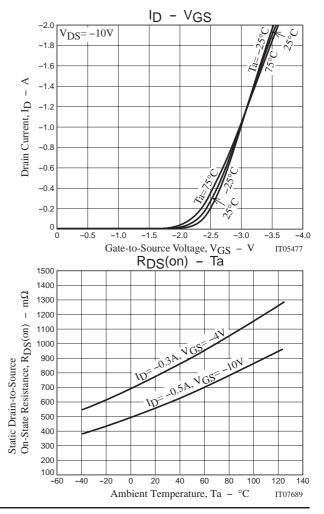
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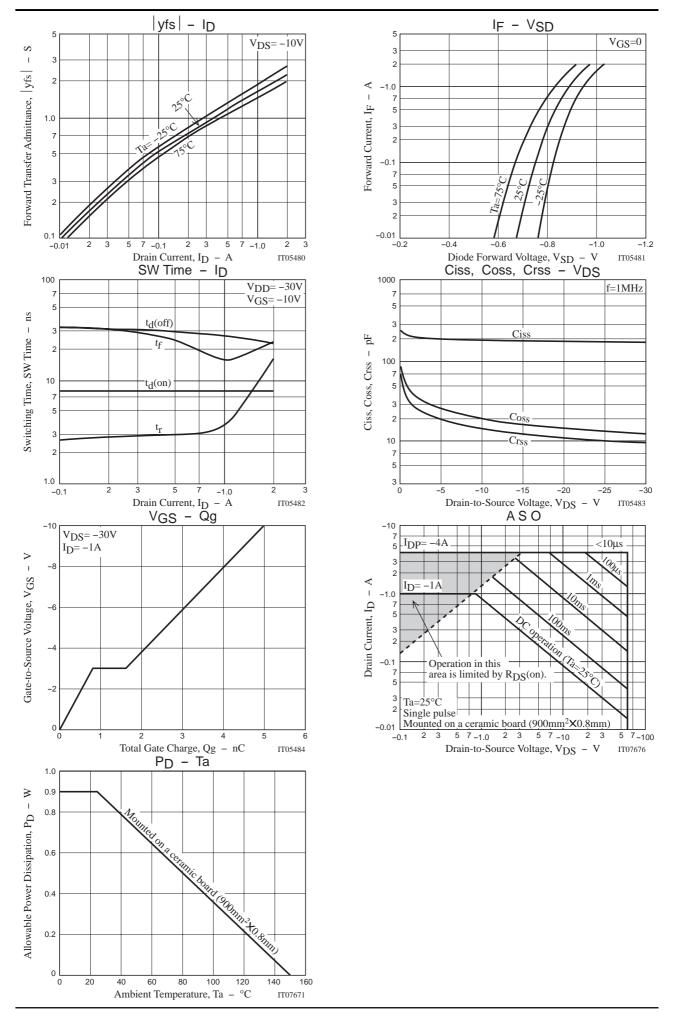


Switching Time Test Circuit









Note on usage: Since the MCH3315 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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